

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

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Schedule of Scope to Certificate of Approval Independent Testing Laboratory

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1. Environmental and Reliability Testing of Electronic Components, Assemblies, and Related Materials

Description test	Standard	Remarks
Consumer / Commercial / Industrial (JESD 47) and Automotive / Military accelerated environment reliability stress tests	J-STD-020, JESD22-A101/A102/ A106/A107/A110/A113/A118/A119; IEC- 60068-2-1/2/3/14/ 38/52,	
(Including: Pre-condition / MSL / Accelerated Temperature-Humidity test / Temperature-Humidity with bias test / Temperature Cycling test / Power and temperature cycling / Temperature storage test / IOL / Salt)	MIL-STD-202/750/810/883,JESD JP001; EIA-364-32C, EIAJ ED-4701, AEC-Q200- 001 /004; AEC-Q005/Q006,	Or customer specified test
Consumer/ Commercial / Industrial (JESD 47) and Automotive / Military accelerated lifetime simulation tests. (Including: Temperature, Bias, and Operating Life test / early life failure rate / Endurance and Data retention test / Electro-Migration / Short circuit / Miscellaneous test / Gate Leakage test)	JESD22-A108/A117, JESD61, MIL-STD-202/750/810/883, AEC-Q100-005/006/008/012, AEC-Q101-004/006, Customer standards	Or customer specified test

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